Unit: mm

TOSHIBA Field-Effect Transistor Silicon N / P Channel MOS Type

SSM6L39TU

- O Power Management Switch Applications
- High-Speed Switching Applications

N-ch: 1.5-V drive
 P-ch: 1.8-V drive
 N-ch, P-ch, 2-in-1

• Low ON-resistance Q1 N-ch: $R_{on} = 247 \text{ m}\Omega \text{ (max) } (@V_{GS} = 1.5 \text{ V})$

 $R_{on} = 190 \text{ m}\Omega \text{ (max) (@V_{GS} = 1.8 V)}$

 $R_{on} = 139 \text{ m}\Omega \text{ (max) (@V_{GS} = 2.5 V)}$

Q2 P-ch: $R_{on} = 430 \text{ m}\Omega \text{ (max) (@V}_{GS} = -1.8 \text{ V)}$

 $R_{on} = 294 \text{ m}\Omega \text{ (max) (@V_{GS} = -2.5 V)}$

Q1 Absolute Maximum Ratings (Ta = 25°C)

| Characteristics | | Symbol | Rating | Unit |
|----------------------|-------|-----------------|--------|------|
| Drain-source voltage | | V_{DSS} | 20 | V |
| Gate-source voltage | | V_{GSS} | ±10 | ٧ |
| Drain current | DC | ID | 1.6 | ۸ |
| | Pulse | I _{DP} | 3.2 | А |

Q2 Absolute Maximum Ratings (Ta = 25°C)

| | | J - (| | |
|----------------------|-------|------------------|--------|------|
| Characteristics | | Symbol | Rating | Unit |
| Drain-source voltage | | V_{DSS} | -20 | V |
| Gate-source voltage | | V _{GSS} | ±8 | V |
| Drain current | DC | I _D | -1.5 | Α |
| | Pulse | I _{DP} | -3 | A |

Absolute Maximum Ratings (Ta = 25 °C) (Q1, Q2 Common)

| Characteristics | Symbol | Rating | Unit | |
|---------------------------|-------------------------|------------|------|--|
| Drain power dissipation | P _D (Note 1) | 500 | mW | |
| Channel temperature | T _{ch} | 150 | °C | |
| Storage temperature range | T _{stg} | -55 to 150 | °C | |

2.1±0.1 1.7±0.1 1.7±0.1 1.9000+20 1.Source1 4.Source2 2.Gate1 5.Gate2 3.Drain2 6.Drain1 UF6 JEDEC —

JEITA —

TOSHIBA 2-2T1B

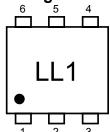
Weight: 7.0 mg (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

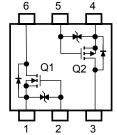
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note1: Mounted on an FR4 board. (total dissipation) $(25.4 \text{ mm} \times 25.4 \text{ mm} \times 1.6 \text{ mm}, \text{Cu Pad} : 645 \text{ mm}^2)$

Marking



Equivalent Circuit (top view)





Q1 Electrical Characteristics (Ta = 25°C)

| Cha | racteristics | Symbol | Test Conditions | Min | Тур. | Max | Unit |
|--------------------------------|------------------------------|----------------------|-------------------------------------------------------------------------|------|------|------|------|
| Drain-source breakdown voltage | | V (BR) DSS | $I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$ | 20 | _ | _ | - V |
| | | V (BR) DSX | I _D = 1 mA, V _{GS} = -10 V | 12 | _ | _ | |
| Drain cutoff current | | I _{DSS} | V _{DS} =20 V, V _{GS} = 0 V | _ | _ | 1 | μА |
| Gate leakage curr | ent | I _{GSS} | $V_{GS} = \pm 10 \text{ V}, V_{DS} = 0 \text{ V}$ | _ | _ | ±1 | μА |
| Gate threshold vol | tage | V _{th} | $V_{DS} = 3 \text{ V}, I_D = 1 \text{ mA}$ | 0.35 | _ | 1.0 | V |
| Forward transfer a | dmittance | Y _{fs} | $V_{DS} = 3 \text{ V}, I_D = 1A$ (Note 2) | 2.5 | 5.0 | _ | S |
| | | | $I_D = 1 \text{ A}, V_{GS} = 4.0 \text{ V}$ (Note 2) | _ | 87 | 119 | |
| Drain aguras ON | rociotanos | R _{DS (ON)} | I _D = 1 A, V _{GS} = 2.5 V (Note 2) | _ | 105 | 139 | |
| Drain-source Oiv-i | Drain-source ON-resistance | | I _D = 0.8 A, V _{GS} = 1.8 V (Note 2) | _ | 125 | 190 | - mΩ |
| | | | I _D = 0.3 A, V _{GS} = 1.5 V (Note 2) | _ | 145 | 247 | |
| Input capacitance | Input capacitance | | | _ | 260 | _ | pF |
| Output capacitance | | C _{oss} | V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz | _ | 45 | _ | |
| Reverse transfer of | Reverse transfer capacitance | | | _ | 37 | _ | |
| Total Gate Charge |) | Q_g | \/ 10 \/ | _ | 7.5 | _ | |
| Gate-Source Charge | | Q_{gs} | V _{DS} = 10 V, I _D = 1.6 A V _{GS} = 4 V | _ | 5.6 | _ | nC |
| Gate-Drain Charge | | Q_{gd} | 1 VGS - 4 V | _ | 1.9 | _ | |
| Switching time | Turn-on time | t _{on} | V _{DD} = 10 V, I _D = 0.5 A | _ | 8.3 | _ | 20 |
| | Turn-off time | t _{off} | $V_{GS} = 0$ to 2.5 V, $R_{G} = 4.7 \Omega$ | _ | 11.5 | _ | ns |
| Drain-source forward voltage | | V _{DSF} | $I_D = -1.6 \text{ A}, V_{GS} = 0 \text{ V}$ (Note 2) | _ | -0.8 | -1.2 | V |

Q2 Electrical Characteristics (Ta = 25°C)

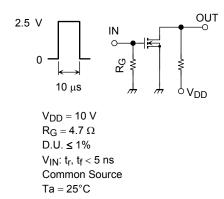
| Chara | cteristics | Symbol | Test Conditions | | Min | Тур. | Max | Unit |
|--------------------------------|---------------|----------------------|-------------------------------------------------------------------|----------|------|------|------|------|
| Drain-source breakdown voltage | | V (BR) DSS | | | -20 | _ | _ | ٧ |
| | | V (BR) DSX | | | -12 | _ | _ | |
| Drain cutoff currer | nt | I _{DSS} | V _{DS} = -20 V, V _{GS} = 0 V | | _ | _ | -10 | μА |
| Gate leakage curr | ent | I _{GSS} | $V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V}$ | | _ | _ | ±1 | μА |
| Gate threshold vo | Itage | V _{th} | $V_{DS} = -3 \text{ V}, I_{D} = -1 \text{ mA}$ | | -0.3 | _ | -1.0 | V |
| Forward transfer a | admittance | Y _{fs} | $V_{DS} = -3 \text{ V}, I_{D} = -1 \text{ A}$ | (Note 2) | 1.6 | 3.2 | _ | S |
| Drain-source ON-resistance | | | I _D = -1.0 A, V _{GS} = -4 V | (Note 2) | _ | 160 | 213 | mΩ |
| | | R _{DS (ON)} | I _D = -0.8 A, V _{GS} = -2.5 V | (Note 2) | _ | 210 | 294 | |
| | | | I _D = -0.1 A, V _{GS} = -1.8 V | (Note 2) | | 280 | 430 | |
| Input capacitance | | C _{iss} | $V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | _ | 250 | _ | pF |
| Output capacitance | | Coss | | | _ | 43 | _ | |
| Reverse transfer capacitance | | C _{rss} | | | _ | 35 | _ | |
| Total Gate Charge | e | Q_g | | | _ | 6.4 | _ | |
| Gate-Source Charge | | Q_gs | V_{DS} = -10 V, I_{D} = -1.5 A V_{GS} = -4 V | | _ | 4.5 | _ | nC |
| Gate-Drain Charge | | Q_{gd} | | | _ | 1.9 | _ | |
| Switching time | Turn-on time | t _{on} | $V_{DD} = -10 \text{ V}, I_D = -1 \text{ A},$ | | _ | 12 | _ | |
| | Turn-off time | t _{off} | $V_{GS} = 0 \text{ to } -2.5 \text{ V}, R_G = 4.7 \Omega$ | 1 | _ | 11.2 | _ | ns |
| Drain-source forward voltage | | V _{DSF} | I _D = 1.5 A, V _{GS} = 0 V | (Note 2) | _ | 0.88 | 1.2 | V |

Note 2: Pulse test

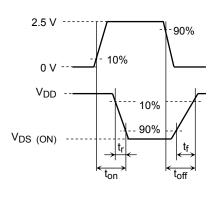
Q1 Switching Time Test Circuit

(a) Test Circuit





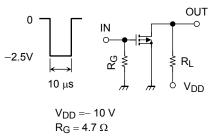




Q2 Switching Time Test Circuit

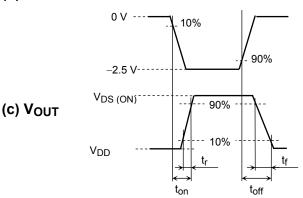
(a) Test Circuit





 $D.U. \leq 1\%$ $V_{IN}\text{: }t_{\text{r}}\text{, }t_{\text{f}}<5\text{ ns}$

Common Source $Ta = 25^{\circ}C$



Q1 Usage Considerations

Let Vth be the voltage applied between gate and source that causes the drain current (ID) to below (1 mA for the Q1 of the SSM6L359TU). Then, for normal switching operation, $V_{GS(on)}$ must be higher than V_{th} , and $V_{GS(off)}$ must be lower than V_{th.} This relationship can be expressed as: V_{GS(off)} < V_{th} < V_{GS(on)}.

Take this into consideration when using the device.

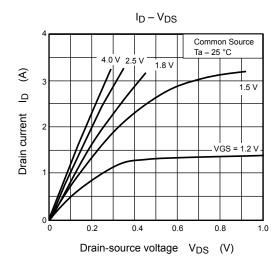
Q2 Usage Considerations

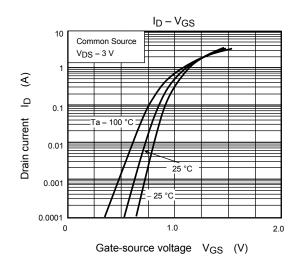
Let V_{th} be the voltage applied between gate and source that causes the drain current (I_D) to below (-1 mA for the Q2 of the SSM6L39TU). Then, for normal switching operation, $V_{GS(on)}$ must be higher than V_{th} , and $V_{GS(off)}$ must be lower than V_{th.} This relationship can be expressed as: V_{GS(off)} < V_{th} < V_{GS(on)}. Take this into consideration when using the device.

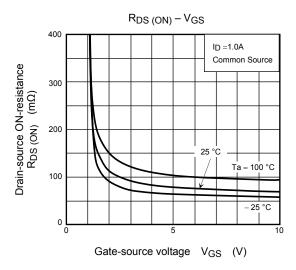
Handling Precaution

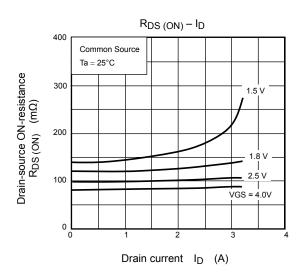
When handling individual devices that are not yet mounted on a circuit board, make sure that the environment is protected against electrostatic discharge. Operators should wear antistatic clothing, and containers and other objects that come into direct contact with devices should be made of antistatic materials.

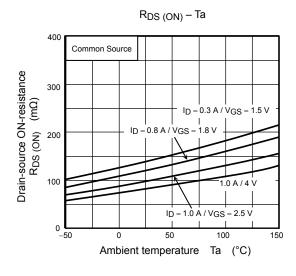
Q1 (N-ch MOSFET)

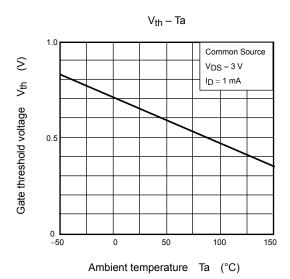




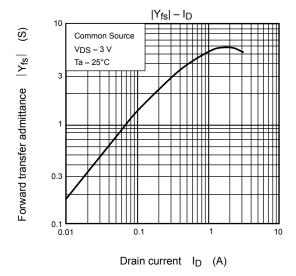


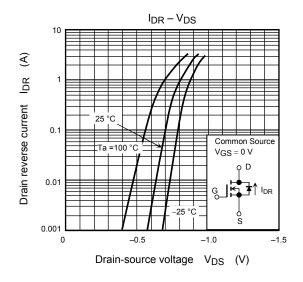


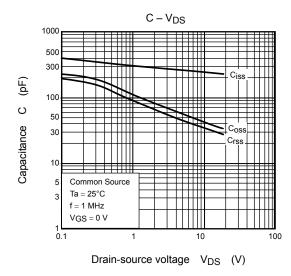


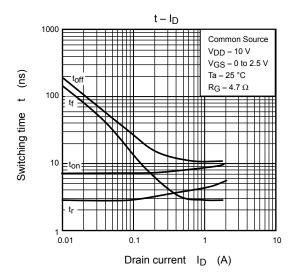


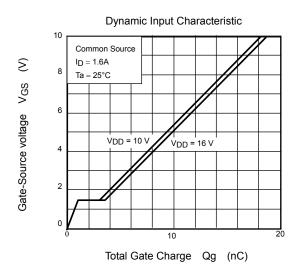
Q1 (N-ch MOSFET)







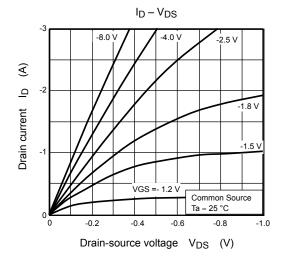


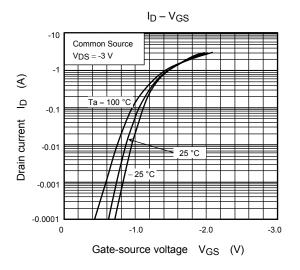


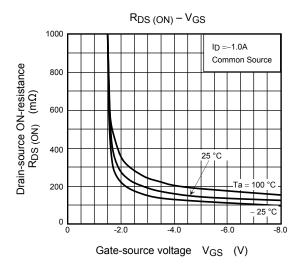
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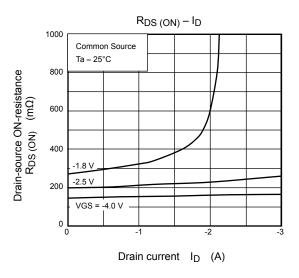
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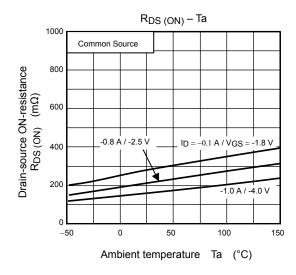
Q2 (P-ch MOSFET)

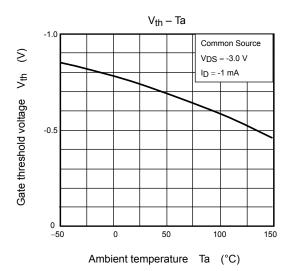






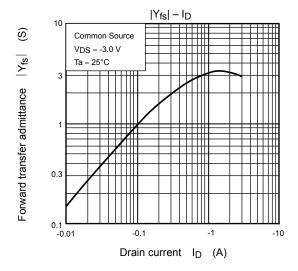


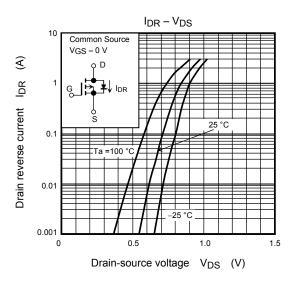


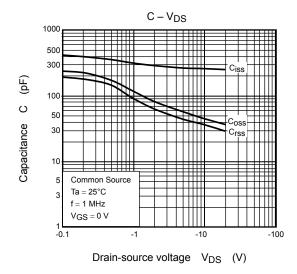


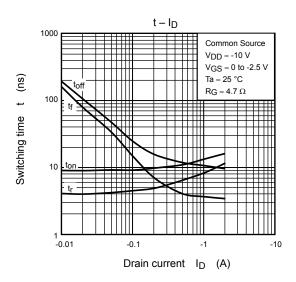
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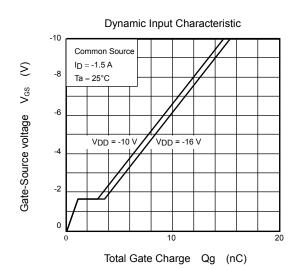
Q2 (P-ch MOSFET)



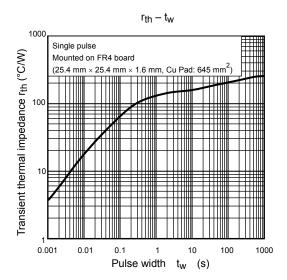


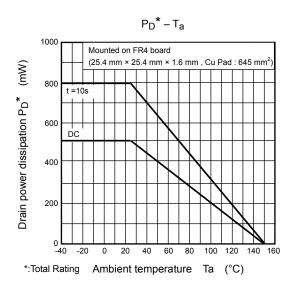






Q1,Q2 Common





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